

14-Bit 400-MSPS Digital-to-Analog Converter

FEATURES

- 400-MSPS Update Rate
- Controlled Baseline
 - One Assembly
 - One Test Site
 - One Fabrication Site
- Extended Temperature Performance of -55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- LVDS-Compatible Input Interface
- Spurious-Free Dynamic Range (SFDR) to Nyquist
 - 69 dBc at 70 MHz IF, 400 MSPS
- W-CDMA Adjacent Channel Power Ratio (ACPR)
 - 73 dBc at 30.72-MHz IF, 122.88 MSPS
 - 71 dBc at 61.44-MHz IF, 245.76 MSPS
- Differential Scalable Current Outputs: 2 mA to 20 mA
- On-Chip 1.2-V Reference
- Single 3.3-V Supply Operation

- Power Dissipation: 660 mW at $f_{\text{CLK}} = 400 \text{ MSPS}$, $f_{\text{OUT}} = 20 \text{ MHz}$
- Package: 48-Pin PowerPAD™ Thermally-Enhanced Thin Quad Flat Pack (HTQFP) $T_{\text{JA}} = 29.1^{\circ}\text{C/W}$

APPLICATIONS

- Cellular Base Transceiver Station Transmit Channel:
 - CDMA: WCDMA, CDMA2000, IS-95
 - TDMA: GSM, IS-136, EDGE/GPRS
 - Supports Single-Carrier and Multicarrier Applications
- Test and Measurement: Arbitrary Waveform Generation
- Military Communications

DESCRIPTION/ORDERING INFORMATION

The DAC5675 is a 14-bit resolution high-speed digital-to-analog converter (DAC). The DAC5675 is designed for high-speed digital data transmission in wired and wireless communication systems, high-frequency direct-digital synthesis (DDS), and waveform reconstruction in test and measurement applications. The DAC5675 has excellent spurious-free dynamic range (SFDR) at high intermediate frequencies, which makes it well-suited for multicarrier transmission in TDMA- and CDMA-based cellular base transceiver stations (BTSS).

The DAC5675 operates from a single-supply voltage of 3.3 V. Power dissipation is 660 mW at $f_{\text{CLK}} = 400 \text{ MSPS}$, $f_{\text{OUT}} = 70 \text{ MHz}$. The DAC5675 provides a nominal full-scale differential current output of 20 mA, supporting both single-ended and differential applications. The output current can be directly fed to the load with no additional external output buffer required. The output is referred to the analog supply voltage AV_{DD} .

The DAC5675 comprises a low-voltage differential signaling (LVDS) interface for high-speed digital data input. LVDS features a low differential voltage swing with a low constant power consumption across frequency, allowing for high-speed data transmission with low noise levels; that is, with low electromagnetic interference (EMI). LVDS is typically implemented in low-voltage digital CMOS processes, making it the ideal technology for high-speed interfacing between the DAC5675 and high-speed low-voltage CMOS ASICs or FPGAs. The DAC5675 current-source-array architecture supports update rates of up to 400 MSPS. On-chip edge-triggered input latches provide for minimum setup and hold times, thereby relaxing interface timing.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments.

The DAC5675 has been specifically designed for a differential transformer-coupled output with a 50-Ω doubly-terminated load. With the 20-mA full-scale output current, both a 4:1 impedance ratio (resulting in an output power of 4 dBm) and 1:1 impedance ratio transformer (–2 dBm) is supported. The last configuration is preferred for optimum performance at high output frequencies and update rates. The outputs are terminated to AVDD and have voltage compliance ranges from AVDD – 1 to AVDD + 0.3 V.

An accurate on-chip 1.2-V temperature-compensated bandgap reference and control amplifier allows the user to adjust this output current from 20 mA down to 2 mA. This provides 20-dB gain range control capabilities. Alternatively, an external reference voltage may be applied. The DAC5675 features a SLEEP mode, which reduces the standby power to approximately 18 mW.

The DAC5675 is available in a 48-pin PowerPAD™ thermally-enhanced thin quad flat pack (HTQFP). This package increases thermal efficiency in a standard size IC package. The device is specified for operation over the military temperature range of –55°C to 125°C.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

PRODUCT	PACKAGE LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
DAC5675-EP	48 HTQFP	PHP	DAC5675-EP	DAC5675MPHPREP	Tape and reel, 1000
				DAC5675MPHPEP	Tray, 250

(1) For the most current package and ordering information, see the *Package Option Addendum* located at the end of this data sheet.

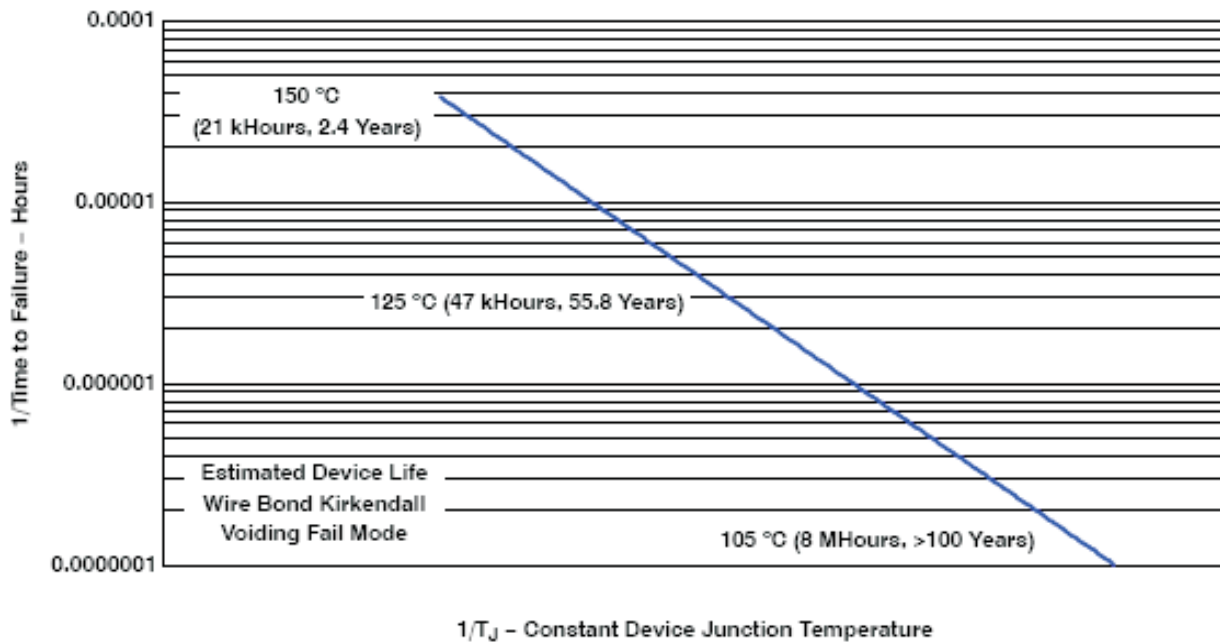
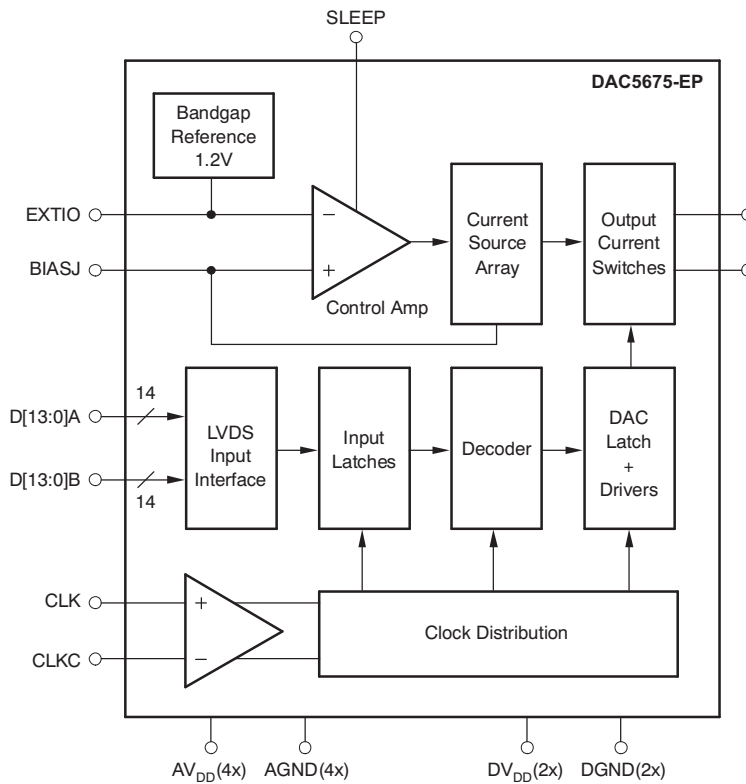
TQFP-48 PACKAGE THERMAL CHARACTERISTICS

PARAMETER	SAME PACKAGE FORM WITHOUT PowerPAD	PowerPAD CONNECTED TO PCB THERMAL PLANE ⁽¹⁾
R _{θJA} Thermal resistance, junction to ambient ⁽¹⁾⁽²⁾	108.71°C/W	29.11°C/W
R _{θJC} Thermal resistance, junction to case ⁽¹⁾⁽²⁾	18.18°C/W	1.14°C/W

(1) Airflow is at 0 LFM (no airflow).

(2) Specified with the PowerPAD bond pad on the backside of the package soldered to a 2-oz CU plate PCB thermal plane

FUNCTIONAL BLOCK DIAGRAM



Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		DAC5675-EP	UNIT
Supply voltage range	AV_{DD} ⁽²⁾	–0.3 to 3.6	V
	DV_{DD} ⁽³⁾	–0.3 to 3.6	
	AV_{DD} to DV_{DD}	–3.6 to 3.6	
Voltage between AGND and DGND		–0.3 to 0.5	V
CLK, CLKC ⁽²⁾		–0.3 to $AV_{DD} + 0.3$	V
Digital input D[13:0]A, D[13:0]B ⁽³⁾ , SLEEP, DLLOFF		–0.3 to $DV_{DD} + 0.3$	V
IOUT1, IOUT2 ⁽²⁾		–1 to $AV_{DD} + 0.3$	V
EXTIO, BIASJ ⁽²⁾		–1 to $AV_{DD} + 0.3$	V
Peak input current (any input)		20	mA
Peak total input current (all inputs)		–30	mA
Operating free-air temperature range, T_A		–55 to 125	°C
Storage temperature range		–65 to 150	°C
Lead temperature 1,6 mm (1/16 in) from the case for 10 s		260	°C

- (1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Measured with respect to AGND
- (3) Measured with respect to DGND

DC Electrical Characteristics

over operating free-air temperature range, typical values at 25°C, $AV_{DD} = 3.3$ V, $DV_{DD} = 3.3$ V, $I_{O(FS)} = 20$ mA (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Resolution			14			Bit
DC Accuracy⁽¹⁾						
INL	Integral nonlinearity	T_{MIN} to T_{MAX}	-4	±1.5	4.6	LSB
DNL	Differential nonlinearity		-2	±0.6	2.2	LSB
Monotonicity			Monotonic 12b Level			
Analog Output						
$I_{O(FS)}$	Full-scale output current		2		20	mA
	Output compliance range	$AV_{DD} = 3.15$ V to 3.45 V, $I_{O(FS)} = 20$ mA	$AV_{DD} - 1$		$AV_{DD} + 0.3$	V
	Offset error			0.01		%FSR
	Gain error	Without internal reference	-10	5	10	%FSR
		With internal reference	-10	2.5	10	
	Output resistance		300			kΩ
	Output capacitance		5			pF
Reference Output						
$V_{(EXTIO)}$	Reference voltage		1.17	1.23	1.29	V
	Reference output current ⁽²⁾			100		nA
Reference Input						
$V_{(EXTIO)}$	Input reference voltage		0.6	1.2	1.25	V
	Input resistance			1		MΩ
	Small-signal bandwidth			1.4		MHz
	Input capacitance			100		pF
Temperature Coefficients						
	Offset drift			12		ppm of FSR/°C
$\Delta V_{(EXTIO)}$	Reference voltage drift			±50		ppm/°C
Power Supply						
AV_{DD}	Analog supply voltage		3.15	3.3	3.6	V
DV_{DD}	Digital supply voltage		3.15	3.3	3.6	V
$I_{(AVDD)}$	Analog supply current ⁽³⁾			115		mA
$I_{(DVDD)}$	Digital supply current ⁽³⁾			85		mA
P_D	Power dissipation	Sleep mode		18		mW
		$AV_{DD} = 3.3$ V, $DV_{DD} = 3.3$ V		660	900	
APSR	Analog and digital power-supply rejection ratio	$AV_{DD} = 3.15$ V to 3.45 V	-0.9	±0.1	0.9	%FSR/V
DPSRR			-0.9	±0.1	0.9	

(1) Measured differential at I_{OUT1} and I_{OUT2} : 25 Ω to AV_{DD}

(2) Use an external buffer amplifier with high impedance input to drive any external load.

(3) Measured at $f_{CLK} = 400$ MSPS and $f_{OUT} = 70$ MHz

AC Electrical Characteristics

over operating free-air temperature range, typical values at 25°C, $V_{DD} = 3.3\text{ V}$, $DV_{DD} = 3.3\text{ V}$, $I_{O(FS)} = 20\text{ mA}$, differential transformer-coupled output, 50-Ω doubly-terminated load (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Analog Output							
f_{CLK}	Output update rate				400	MSPS	
$t_{s(DAC)}$	Output setting time to 0.1%	Transition: code x2000 to x23FF		12		ns	
t_{PD}	Output propagation delay			1		ns	
$t_{r(IOUT)}$	Output rise time, 10% to 90%			2		ns	
$t_{f(IOUT)}$	Output fall time, 90% to 10%			2		ns	
Output noise		$I_{OUTFS} = 20\text{ mA}$		55		$\text{pA}/\sqrt{\text{Hz}}$	
		$I_{OUTFS} = 2\text{ mA}$		30			
AC Linearity							
THD	Total harmonic distortion	$f_{CLK} = 100\text{ MSPS}$, $f_{OUT} = 19.9\text{ MHz}$		73		dBc	
		$f_{CLK} = 160\text{ MSPS}$, $f_{OUT} = 41\text{ MHz}$		72			
		$f_{CLK} = 200\text{ MSPS}$, $f_{OUT} = 70\text{ MHz}$		68			
		$f_{CLK} = 400\text{ MSPS}$	$f_{OUT} = 20.1\text{ MHz}$		72		
			$f_{OUT} = 70\text{ MHz}$		71		
$f_{OUT} = 140\text{ MHz}$			58				
SFDR	Spurious-free dynamic range to Nyquist	$f_{CLK} = 100\text{ MSPS}$, $f_{OUT} = 19.9\text{ MHz}$		73		dBc	
		$f_{CLK} = 160\text{ MSPS}$, $f_{OUT} = 41\text{ MHz}$		73			
		$f_{CLK} = 200\text{ MSPS}$, $f_{OUT} = 70\text{ MHz}$		70			
		$f_{CLK} = 400\text{ MSPS}$	$f_{OUT} = 20.1\text{ MHz}$		73		
			$f_{OUT} = 70\text{ MHz}$		74		
$f_{OUT} = 140\text{ MHz}$			60				
SFDR	Spurious-free dynamic range within a window, 5-MHz span	$f_{CLK} = 100\text{ MSPS}$, $f_{OUT} = 19.9\text{ MHz}$		88		dBc	
		$f_{CLK} = 160\text{ MSPS}$, $f_{OUT} = 41\text{ MHz}$		87			
		$f_{CLK} = 200\text{ MSPS}$, $f_{OUT} = 70\text{ MHz}$		82			
		$f_{CLK} = 400\text{ MSPS}$	$f_{OUT} = 20.1\text{ MHz}$		87		
			$f_{OUT} = 70\text{ MHz}$		82		
$f_{OUT} = 140\text{ MHz}$			75				
ACPR	Adjacent channel power ratio WCDM A with 3.84 MHz BW, 5-MHz channel spacing	$f_{CLK} = 122.88\text{ MSPS}$, IF = 30.72 MHz, See Figure 9		73		dB	
		$f_{CLK} = 245.76\text{ MSPS}$, IF = 61.44 MHz, See Figure 10		71			
		$f_{CLK} = 399.32\text{ MSPS}$, IF = 153.36 MHz, See Figure 12		65			
IMD	Two-tone intermodulation to Nyquist (each tone at -6 dBfs)	$f_{CLK} = 400\text{ MSPS}$, $f_{OUT1} = 70\text{ MHz}$, $f_{OUT2} = 71\text{ MHz}$		73		dBc	
		$f_{CLK} = 400\text{ MSPS}$, $f_{OUT1} = 140\text{ MHz}$, $f_{OUT2} = 141\text{ MHz}$		62			
	Four-tone intermodulation, 15-MHz span, missing center tone (each tone at -16 dBfs)	$f_{CLK} = 156\text{ MSPS}$, $f_{OUT} = 15.6, 15.8, 16.2, 16.4\text{ MHz}$		82			
		$f_{CLK} = 400\text{ MSPS}$, $f_{OUT} = 68.1, 69.3, 71.2, 72\text{ MHz}$		74			

Digital Specifications

over operating free-air temperature range, typical values at 25°C, $AV_{DD} = 3.3\text{ V}$, $DV_{DD} = 3.3\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
LVDS Interface: Nodes D[13:0]A, D[13:0]B						
V_{ITH+}	Positive-going differential input voltage threshold	See LVDS Min/Max Threshold Voltages table		100		mV
V_{ITH-}	Negative-going differential input voltage threshold			-100		mV
Z_T	Internal termination impedance		90	110	132	Ω
C_I	Input capacitance			2		pF
CMOS Interface (SLEEP)						
V_{IH}	High-level input voltage		2	3.3		V
V_{IL}	Low-level input voltage			0	0.8	V
I_{IH}	High-level input current		-100		100	μA
I_{IL}	Low-level input current		-10		10	μA
	Input capacitance			2		pF
Clock Interface (CLK, CLKC)						
CLK-CLKC	Clock differential input voltage		0.4		0.8	V_{PP}
$t_{w(H)}$	Clock pulse width high			1.25		ns
$t_{w(L)}$	Clock pulse width low			1.25		ns
	Clock duty cycle		40%		60%	
V_{CM}	Common-mode voltage range		2 \pm 20%			V
	Input resistance	Node CLK, CLKC		670		Ω
	Input capacitance	Node CLK, CLKC		2		pF
	Input resistance	Differential		1.3		k Ω
	Input capacitance	Differential		1		pF
Timing						
t_{SU}	Input setup time			1.5		ns
t_H	Input hold time			0.25		ns
t_{LPH}	Input latch pulse high time			2		ns
t_{DD}	Digital delay time	DLL disabled, DLLOFF = 1		3		clk

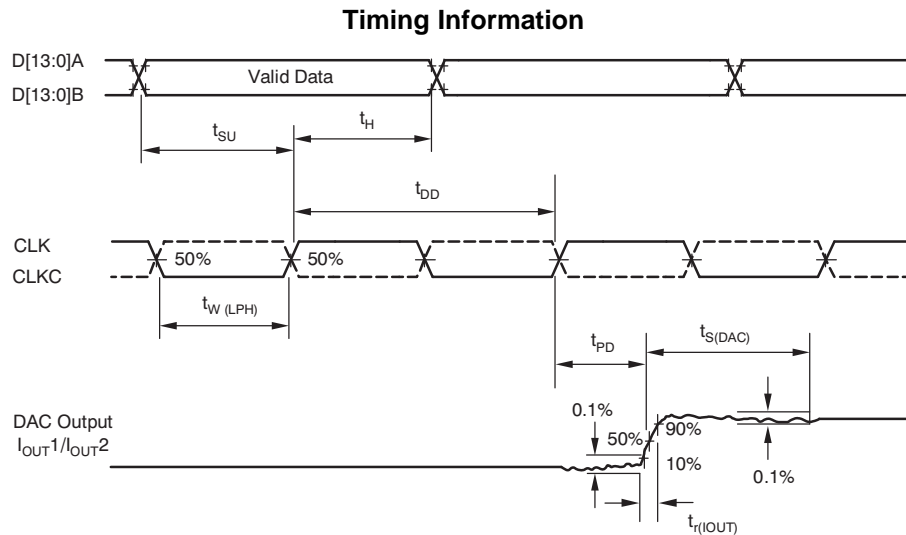


Figure 1. Timing Diagram

Electrical Characteristics⁽¹⁾

over operating free-air temperature range, $AV_{DD} = 3.3\text{ V}$, $DV_{DD} = 3.3\text{ V}$, $I_{O(FS)} = 20\text{ mA}$ (unless otherwise noted)

APPLIED VOLTAGES		RESULTING DIFFERENTIAL INPUT VOLTAGE	RESULTING COMMON-MODE INPUT VOLTAGE	LOGICAL BIT BINARY EQUIVALENT	COMMENT
V_A (V)	V_B (V)	$V_{A,B}$ (mV)	V_{COM} (V)		
1.25	1.15	100	1.2	1	Operation with minimum differential voltage ($\pm 100\text{ mV}$) applied to the complementary inputs versus common-mode range
1.15	1.25	-100	1.2	0	
2.4	2.3	100	2.35	1	
2.3	2.4	-100	2.35	0	
0.1	0	100	0.05	1	
0	0.1	-100	0.05	0	
1.5	0.9	600	1.2	1	Operation with maximum differential voltage ($\pm 600\text{ mV}$) applied to the complementary inputs versus common-mode range
0.9	1.5	-600	1.2	0	
2.4	1.8	600	2.1	1	
1.8	2.4	-600	2.1	0	
0.6	0	600	0.3	1	
0	0.6	-600	0.3	0	

(1) Specifications subject to change.

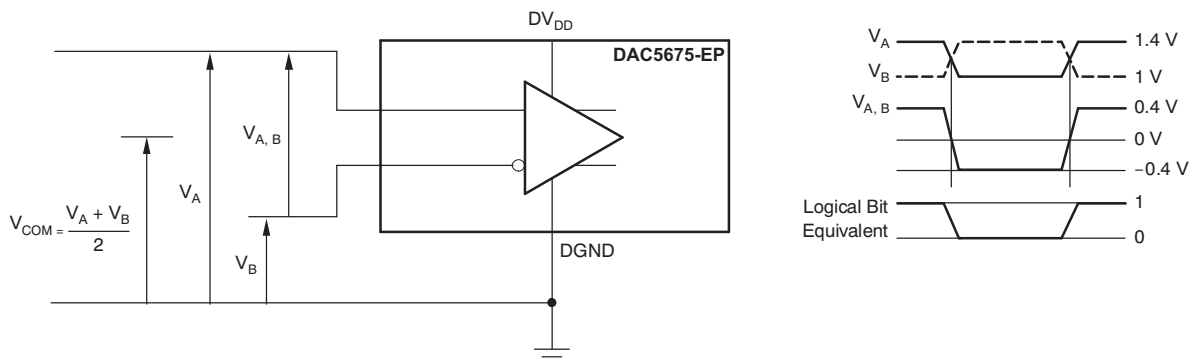
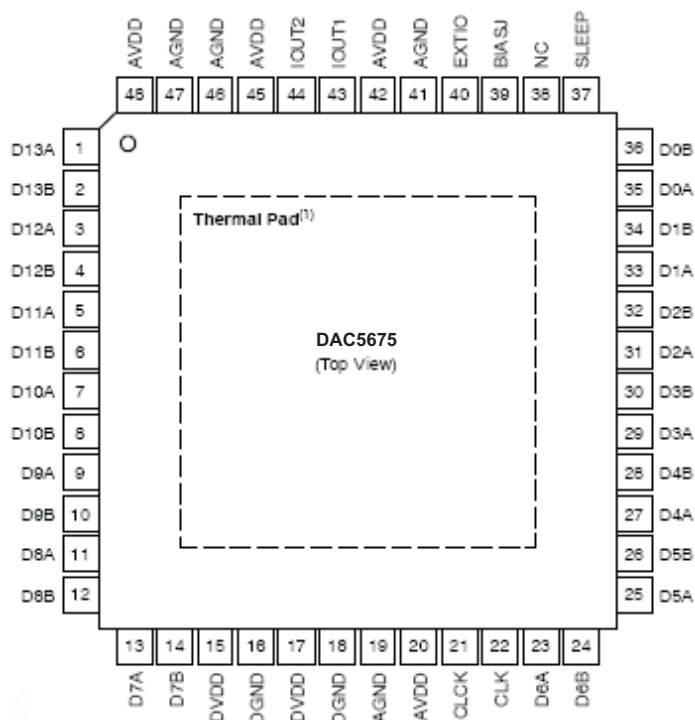


Figure 2. LVDS Timing Test Circuit and Input Test Levels

DEVICE INFORMATION

**PHP PACKAGE
(TOP VIEW)**



- A. Thermal pad size: 4,5mm × 4,5mm (min), 5,5mm × 5,5mm (max)

DEVICE INFORMATION (continued)
TERMINAL FUNCTIONS

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
AGND	19, 41, 46, 47	I	Analog negative supply voltage (ground). Pin 47 is internally connected to the heat slug.
AV _{DD}	20, 42, 45, 48	I	Analog positive supply voltage
BIASJ	39	O	Full-scale output current bias
CLK	22	I	External clock input
CLKC	21	I	Complementary external clock
D[13:0]A	1, 3, 5, 7, 9, 11, 13, 23, 25, 27, 29, 31, 33, 35	I	LVDS positive input, data bits 13–0. D13A is the most significant data bit (MSB). D0A is the least significant data bit (LSB).
D[13:0]B	2, 4, 6, 8, 10, 12, 14, 24, 26, 28, 30, 32, 34, 36	I	LVDS negative input, data bits 13–0. D13B is the most significant data bit (MSB). D0B is the least significant data bit (LSB).
DGND	16, 18	I	Digital negative supply voltage (ground)
DV _{DD}	15, 17	I	Digital positive supply voltage
EXTIO	40	I/O	Internal reference output or external reference input. Requires a 0.1- μ F decoupling capacitor to AGND when used as reference output.
IOUT1	43	O	DAC current output. Full-scale when all input bits are set 1. Connect the reference side of the DAC load resistors to AV _{DD} .
IOUT2	44	O	DAC complementary current output. Full-scale when all input bits are 0. Connect the reference side of the DAC load resistors to AV _{DD} .
NC	38		Not connected in chip. Can be high or low.
SLEEP	37	I	Asynchronous hardware power-down input. Active high. Internal pulldown.

TYPICAL CHARACTERISTICS

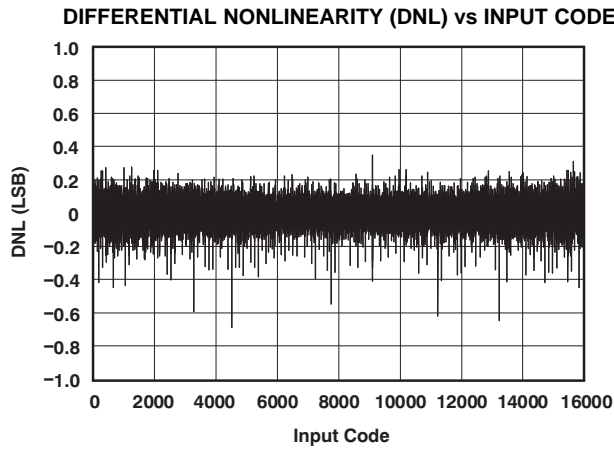


Figure 3.

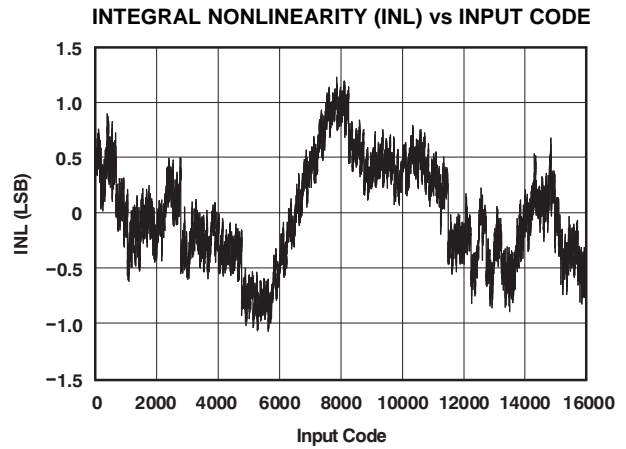


Figure 4.

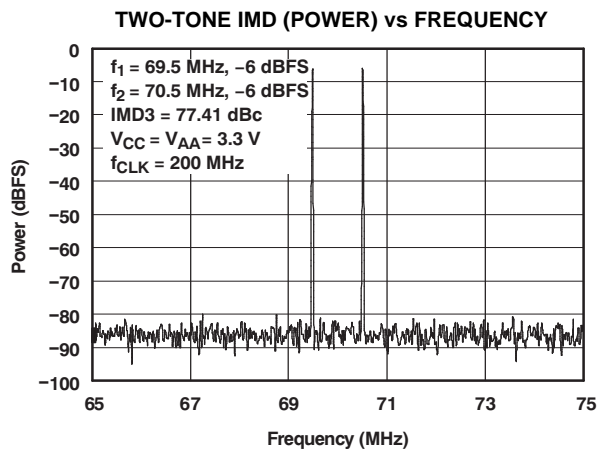


Figure 5.

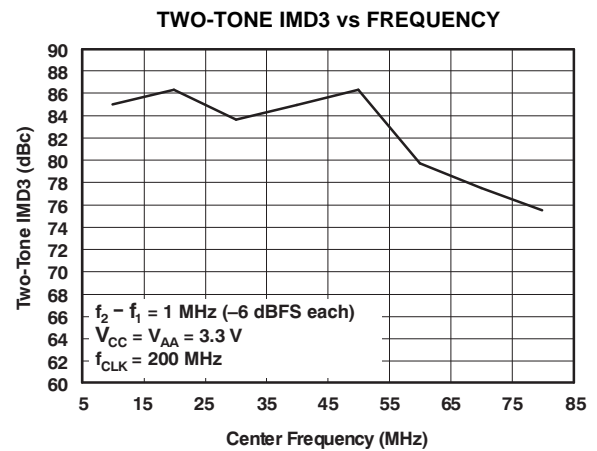


Figure 6.

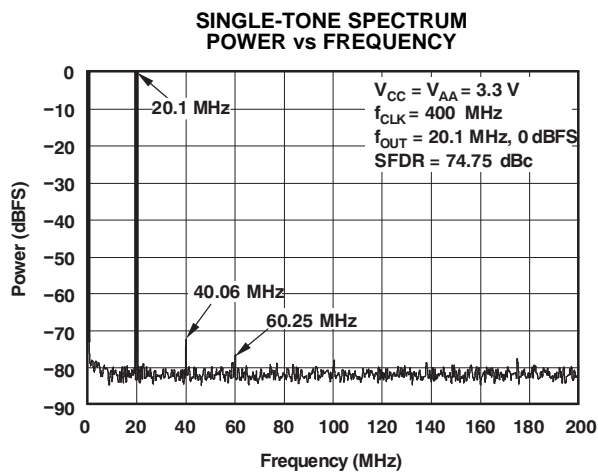


Figure 7.

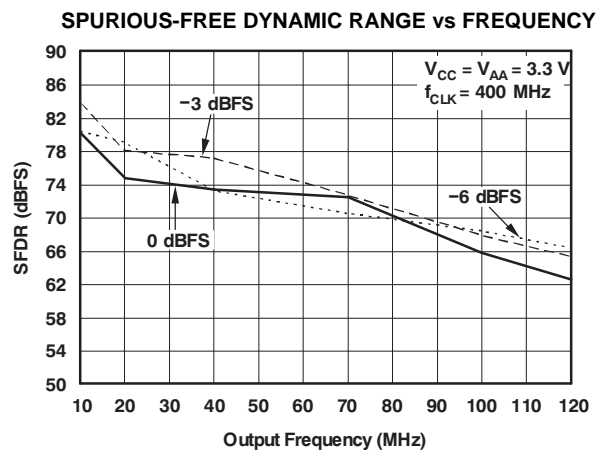


Figure 8.

TYPICAL CHARACTERISTICS (continued)

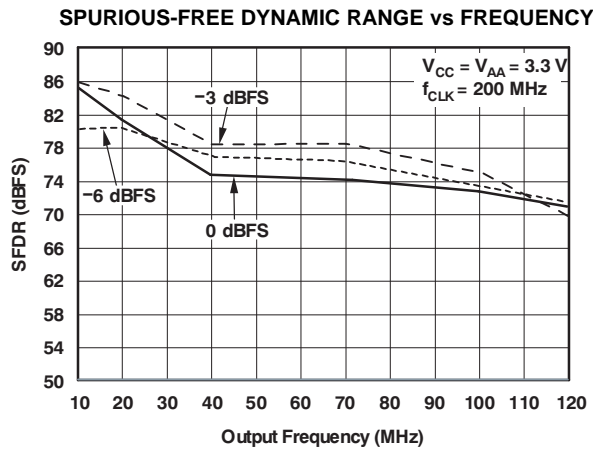


Figure 9.

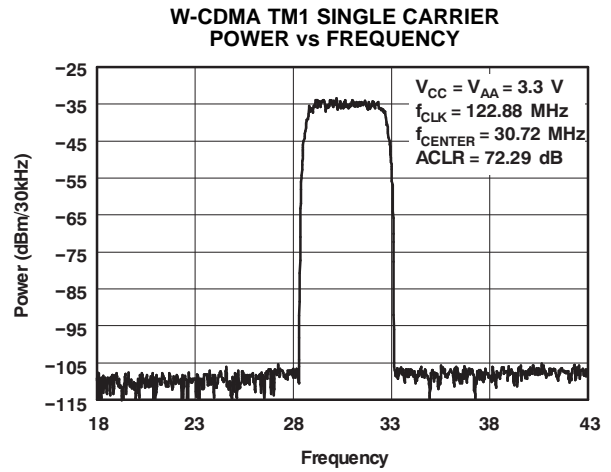


Figure 10.

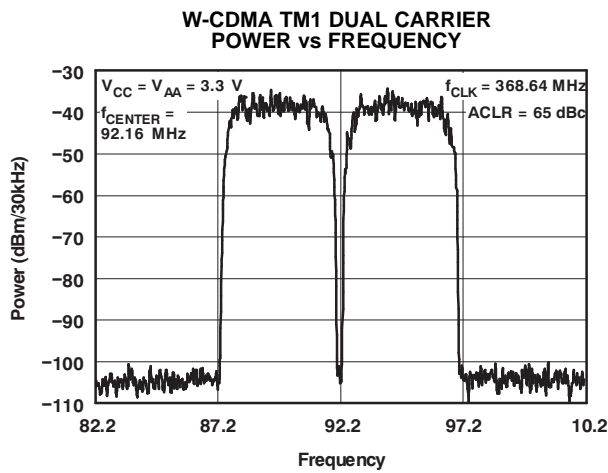


Figure 11.

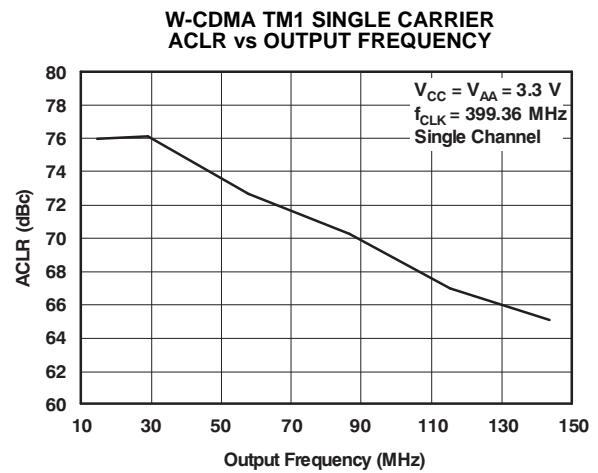


Figure 12.

APPLICATION INFORMATION

Detailed Description

Figure 13 shows a simplified block diagram of the current steering DAC5675. The DAC5675 consists of a segmented array of NPN-transistor current sources, capable of delivering a full-scale output current up to 20 mA. Differential current switches direct the current of each current source to either one of the complementary output nodes IOUT1 or IOUT2. The complementary current output enables differential operation, canceling out common-mode noise sources (digital feedthrough, on-chip, and PCB noise), dc offsets, and even-order distortion components, and doubling signal output power.

The full-scale output current is set using an external resistor (R_{BIAS}) in combination with an on-chip bandgap voltage reference source (1.2 V) and control amplifier. The current (I_{BIAS}) through resistor R_{BIAS} is mirrored internally to provide a full-scale output current equal to 16 times I_{BIAS} . The full-scale current is adjustable from 20 mA down to 2 mA by using the appropriate bias resistor value.

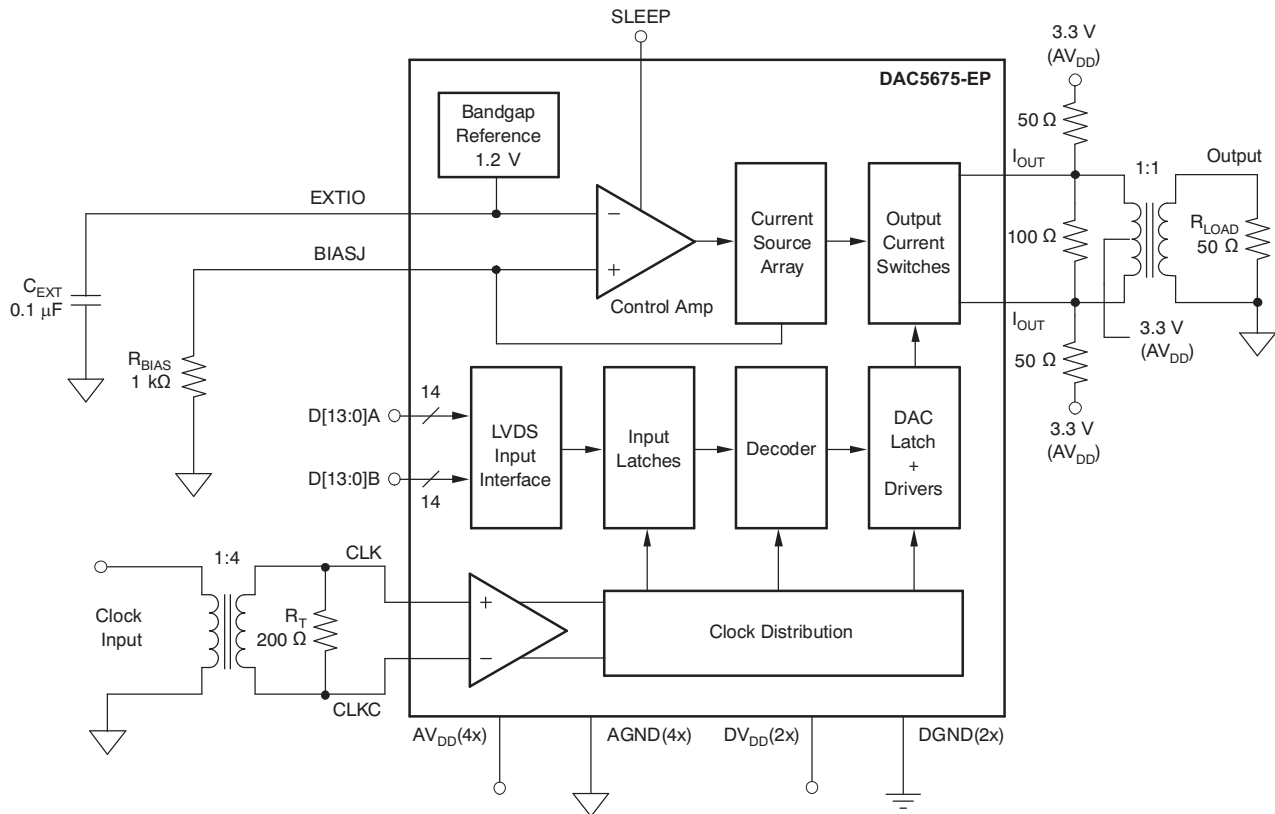


Figure 13. Application Schematic

APPLICATION INFORMATION (continued)

Digital Inputs

The DAC5675 uses a low-voltage differential signaling (LVDS) bus input interface. The LVDS features a low differential voltage swing with low constant power consumption (4 mA per complementary data input) across frequency. The differential characteristic of LVDS allows for high-speed data transmission with low electromagnetic interference (EMI) levels. The LVDS input minimum and maximum input threshold table lists the LVDS input levels. Figure 14 shows the equivalent complementary digital input interface for the DAC5675, valid for pins D[13:0]A and D[13:0]B. Note that the LVDS interface features internal 110-Ω resistors for proper termination. Figure 2 shows the LVDS input timing measurement circuit and waveforms. A common-mode level of 1.2 V and a differential input swing of 0.8 V_{PP} is applied to the inputs.

Figure 15 shows a schematic of the equivalent CMOS/TTL-compatible digital inputs of the DAC5675, valid for the SLEEP pin.

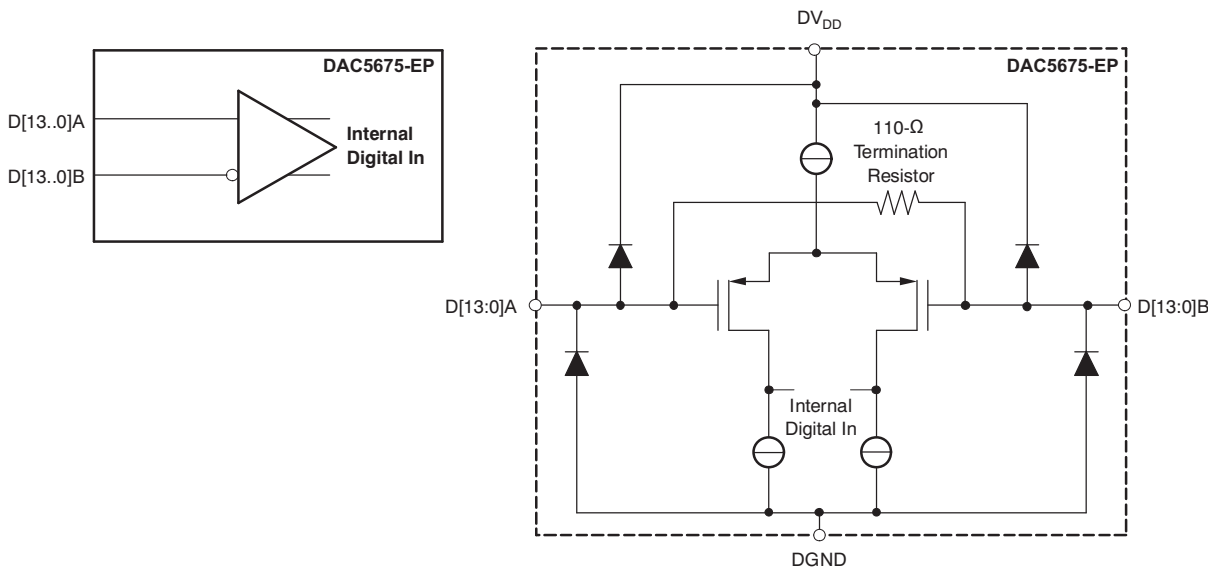


Figure 14. LVDS Digital Equivalent Input

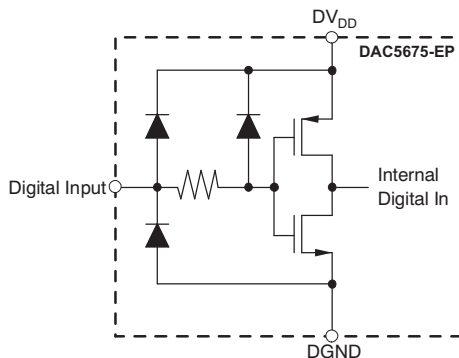


Figure 15. CMOS/TTL Digital Equivalent Input

Clock Input

The DAC5675 features differential LVPECL-compatible clock inputs (CLK, CLKC). Figure 16 shows the equivalent schematic of the clock input buffer. The internal biasing resistors set the input common-mode voltage to approximately 2 V, while the input resistance is typically 670 Ω. A variety of clock sources can be ac-coupled to the device, including a sine-wave source (see Figure 17).

APPLICATION INFORMATION (continued)

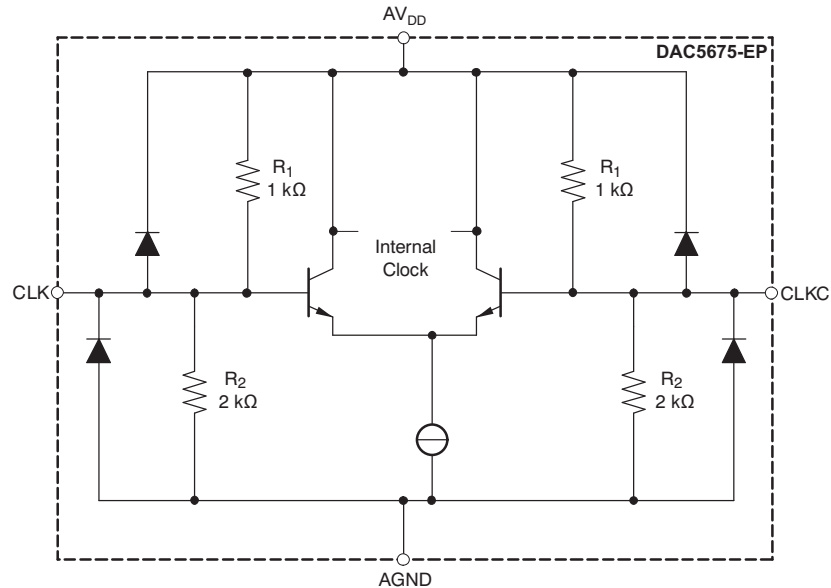


Figure 16. Clock Equivalent Input

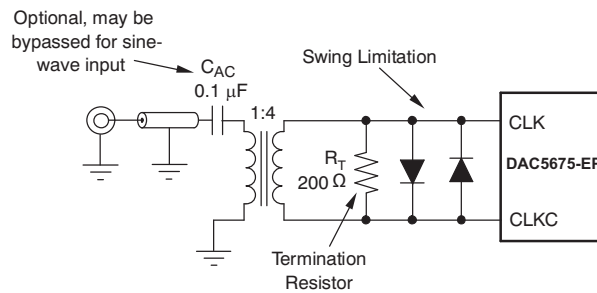


Figure 17. Driving the DAC5675 With a Single-Ended Clock Source Using a Transformer

To obtain best ac performance, the DAC5675 clock input should be driven with a differential LVPECL or sine-wave source as shown in Figure 18 and Figure 19. Here, the potential of V_{TT} should be set to the termination voltage required by the driver along with the proper termination resistors (R_T). The DAC5675 clock input can also be driven single ended; this is shown in Figure 20.

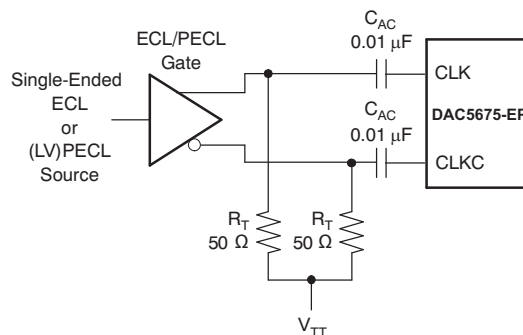


Figure 18. Driving the DAC5675 With a Single-Ended ECL/PECL Clock Source

APPLICATION INFORMATION (continued)

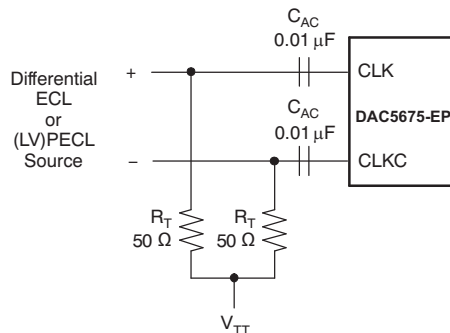


Figure 19. Driving the DAC5675 With a Differential ECL/PECL Clock Source

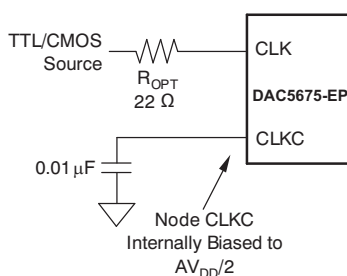


Figure 20. Driving the DAC5675 With a Single-Ended TTL/CMOS Clock Source

Supply Inputs

The DAC5675 comprises separate analog and digital supplies, that is AV_{DD} and DV_{DD} , respectively. These supply inputs can be set independently from 3.6 V down to 3.15 V.

DAC Transfer Function

The DAC5675 delivers complementary output currents I_{OUT1} and I_{OUT2} . The DAC supports straight binary coding, with D13 being the MSB and D0 the LSB. (For ease of notation, we denote D13–D0 as the logical bit equivalent of the complementary LVDS inputs D[13:0]A and D[13:0]B). Output current I_{OUT1} equals the approximate full-scale output current when all input bits are set high, when the binary input word has the decimal representation 16383. Full-scale output current flows through terminal I_{OUT2} when all input bits are set low (mode 0, straight binary input). The relation between I_{OUT1} and I_{OUT2} can thus be expressed as:

$$I_{OUT1} = I_{O(FS)} - I_{OUT2} \quad (1)$$

where $I_{O(FS)}$ is the full-scale output current. The output currents can be expressed as:

$$I_{OUT1} = \frac{I_{O(FS)} \times \text{CODE}}{16384} \quad (2)$$

$$I_{OUT2} = \frac{I_{O(FS)} \times (16383 - \text{CODE})}{16384} \quad (3)$$

where CODE is the decimal representation of the DAC data input word. Output currents I_{OUT1} and I_{OUT2} drive a load R_L . R_L is the combined impedance for the termination resistance and/or transformer load resistance, R_{LOAD} (see Figure 22 and Figure 23). This would translate into single-ended voltages V_{OUT1} and V_{OUT2} at terminal I_{OUT1} and I_{OUT2} , respectively, of Equation 4 and Equation 5:

APPLICATION INFORMATION (continued)

$$V_{OUT1} = I_{OUT1} \times R_L = \frac{(\text{CODE} \times I_{O(FS)}) \times R_L}{16384} \quad (4)$$

$$V_{OUT2} = I_{OUT2} \times R_L = \frac{(16383 - \text{CODE}) \times I_{O(FS)} \times R_L}{16384} \quad (5)$$

Thus, the differential output voltage $V_{OUT(DIFF)}$ can be expressed as:

$$V_{OUT(DIFF)} = V_{OUT1} - V_{OUT2} = \frac{(2\text{CODE} - 16383) \times I_{O(FS)} \times R_L}{16384} \quad (6)$$

Equation 6 shows that applying the differential output results in doubling the signal power delivered to the load. Since the output currents I_{OUT1} and I_{OUT2} are complementary, they become additive when processed differentially. Care should be taken not to exceed the compliance voltages at nodes I_{OUT1} and I_{OUT2} , which leads to increased signal distortion.

Reference Operation

The DAC5675 has a bandgap reference and control amplifier for biasing the full-scale output current. The full-scale output current is set by applying an external resistor R_{BIAS} . The bias current I_{BIAS} through resistor R_{BIAS} is defined by the on-chip bandgap reference voltage and control amplifier. The full-scale output current equals 16 times this bias current. The full-scale output current $I_{O(FS)}$ is thus expressed as [Equation 7](#):

$$I_{O(FS)} = 16 \times I_{BIAS} = \frac{16 \times V_{EXTIO}}{R_{BIAS}} \quad (7)$$

where V_{EXTIO} is the voltage at terminal EXTIO. The bandgap reference voltage delivers a stable voltage of 1.2 V. This reference can be overridden by applying an external voltage to terminal EXTIO. The bandgap reference can additionally be used for external reference operation. In such a case, an external buffer amplifier with high impedance input should be selected in order to limit the bandgap load current to less than 100 nA. The capacitor C_{EXT} may be omitted. Terminal EXTIO serves as either an input or output node. The full-scale output current is adjustable from 20 mA down to 2 mA by varying resistor R_{BIAS} .

Analog Current Outputs

[Figure 21](#) shows a simplified schematic of the current source array output with corresponding switches. Differential NPN switches direct the current of each individual NPN current source to either the positive output node I_{OUT1} or its complementary negative output node I_{OUT2} . The output impedance is determined by the stack of the current sources and differential switches and is $>300 \text{ k}\Omega$ in parallel with an output capacitance of 5 pF.

The external output resistors are referred to the positive supply AV_{DD} .

APPLICATION INFORMATION (continued)

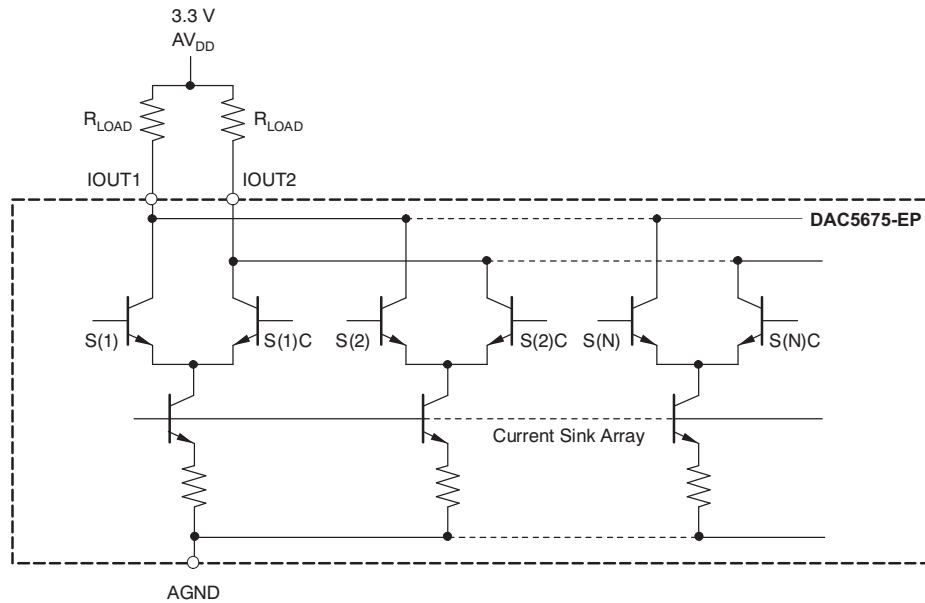


Figure 21. Equivalent Analog Current Output

The DAC5675 can easily be configured to drive a doubly-terminated 50-Ω cable using a properly selected transformer. Figure 22 and Figure 23 show the 1:1 and 4:1 impedance ratio configuration, respectively. These configurations provide maximum rejection of common-mode noise sources and even-order distortion components, thereby doubling the power of the DAC to the output. The center tap on the primary side of the transformer is terminated to AV_{DD}, enabling a dc-current flow for both IOUT1 and IOUT2. Note that the ac performance of the DAC5675 is optimum and specified using a 1:1 differential transformer-coupled output.

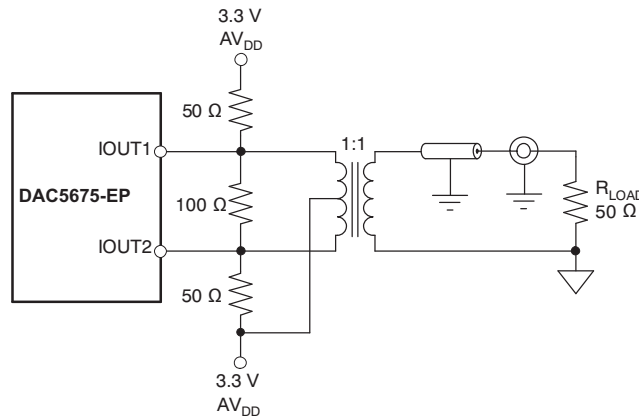


Figure 22. Driving a Doubly-Terminated 50-Ω Cable Using a 1:1 Impedance Ratio Transformer

APPLICATION INFORMATION (continued)

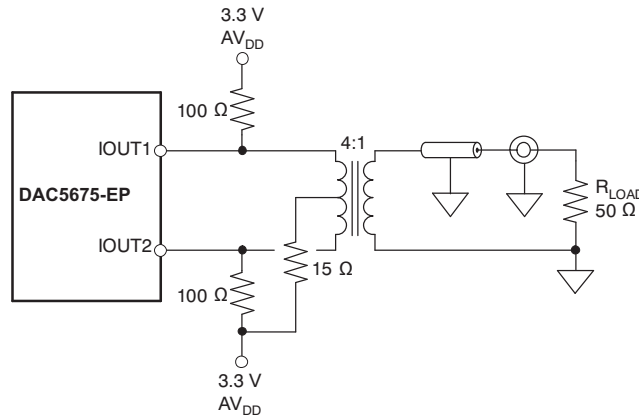


Figure 23. Driving a Doubly-Terminated 50-Ω Cable Using a 4:1 Impedance Ratio Transformer

Figure 24(a) shows the typical differential output configuration with two external matched resistor loads. The nominal resistor load of 25 Ω gives a differential output swing of 1 V_{PP} (0.5 V_{PP} single ended) when applying a 20-mA full-scale output current. The output impedance of the DAC5675 slightly depends on the output voltage at nodes IOOUT1 and IOOUT2. Consequently, for optimum dc-integral nonlinearity, the configuration of Figure 24(b) should be chosen. In this current/voltage (I-V) configuration, terminal IOOUT1 is kept at AV_{DD} by the inverting operational amplifier. The complementary output should be connected to AV_{DD} to provide a dc-current path for the current sources switched to IOOUT1. The amplifier maximum output swing and the full-scale output current of the DAC determine the value of the feedback resistor R_{FB}. The capacitor C_{FB} filters the steep edges of the DAC5675 current output, thereby reducing the operational amplifier slew-rate requirements. In this configuration, the operational amplifier should operate at a supply voltage higher than the resistor output reference voltage AV_{DD} as a result of its positive and negative output swing around AV_{DD}. Node IOOUT1 should be selected if a single-ended unipolar output is desired.

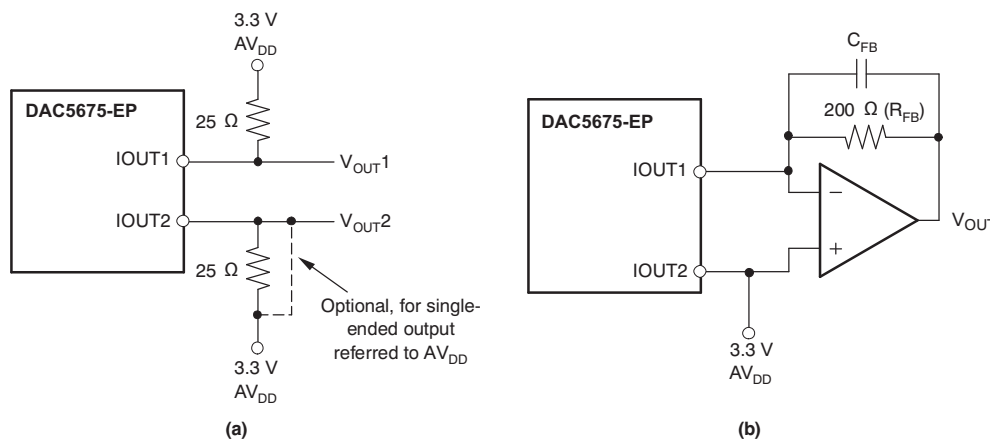


Figure 24. Output Configurations

Sleep Mode

The DAC5675 features a power-down mode that turns off the output current and reduces the supply current to approximately 6 mA. The power-down mode is activated by applying a logic level one to the SLEEP pin, pulled down internally.

DEFINITIONS

Definitions of Specifications and Terminology

Gain error is defined as the percentage error in the ratio between the measured full-scale output current and the value of $16 \times V_{(EXTIO)}/R_{BIAS}$. A $V_{(EXTIO)}$ of 1.25 V is used to measure the gain error with an external reference voltage applied. With an internal reference, this error includes the deviation of $V_{(EXTIO)}$ (internal bandgap reference voltage) from the typical value of 1.25 V.

Offset error is defined as the percentage error in the ratio of the differential output current (IOUT1-IOUT2) and the half of the full-scale output current for input code 8192.

THD is the ratio of the rms sum of the first six harmonic components to the rms value of the fundamental output signal.

SNR is the ratio of the rms value of the fundamental output signal to the rms sum of all other spectral components below the Nyquist frequency, including noise, but excluding the first six harmonics and dc.

SINAD is the ratio of the rms value of the fundamental output signal to the rms sum of all other spectral components below the Nyquist frequency, including noise and harmonics, but excluding dc.

ACPR or adjacent channel power ratio is defined for a 3.84-Mcps 3GPP W-CDMA input signal measured in a 3.84-MHz bandwidth at a 5-MHz offset from the carrier with a 12-dB peak-to-average ratio.

APSSR or analog power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the analog power supply AV_{DD} from the nominal. This is a dc measurement.

DPSSR or digital power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the digital power supply DV_{DD} from the nominal. This is a dc measurement.

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
DAC5675MPHPEP	ACTIVE	HTQFP	PHP	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
DAC5675MPHPREP	ACTIVE	HTQFP	PHP	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
V62/05619-01XE	ACTIVE	HTQFP	PHP	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
V62/05619-02XE	ACTIVE	HTQFP	PHP	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF DAC5675-EP :

- Catalog: [DAC5675](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC5675MPHPREP	HTQFP	PHP	48	1000	330.0	16.4	9.6	9.6	1.5	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS

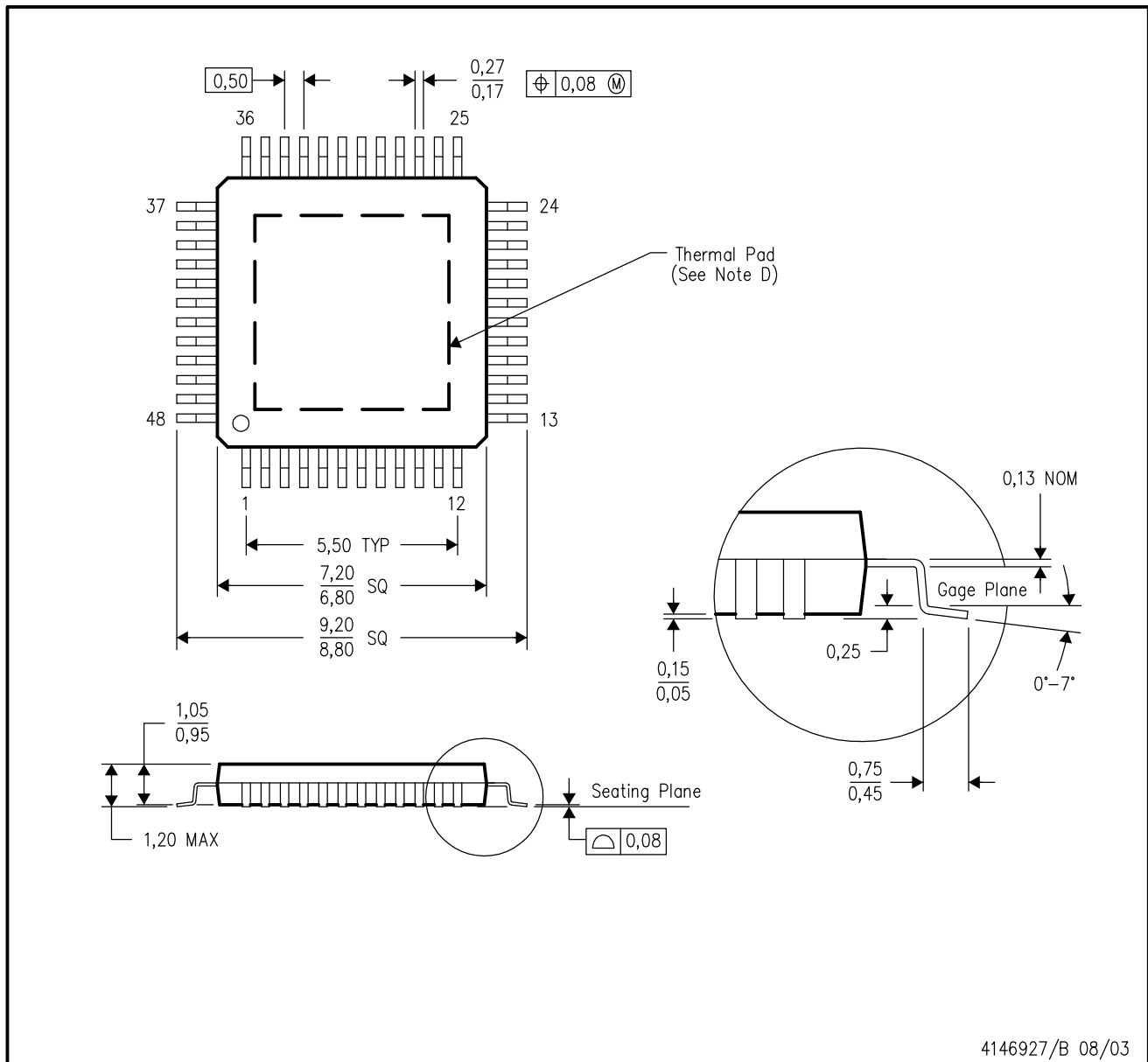


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DAC5675MPHPREP	HTQFP	PHP	48	1000	346.0	346.0	33.0

PHP (S-PQFP-G48)

PowerPAD™ PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - E. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.

THERMAL PAD MECHANICAL DATA

PHP (S-PQFP-G48)

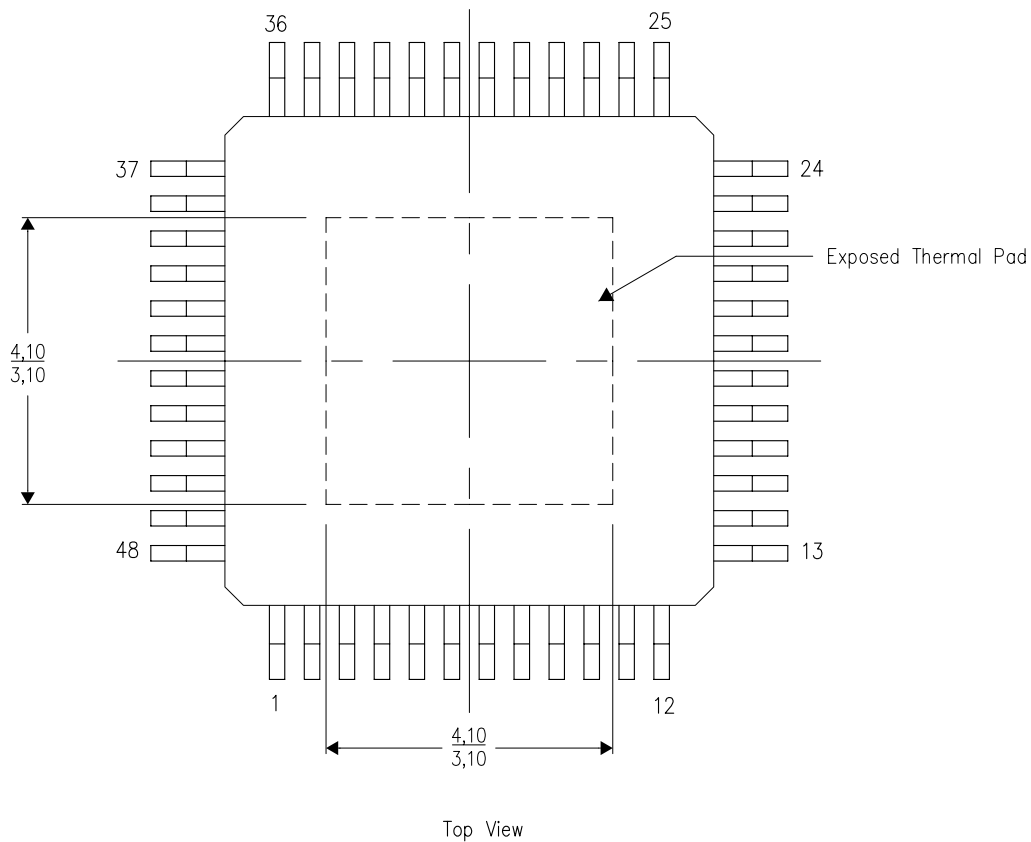
PowerPAD™ PLASTIC QUAD FLATPACK

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Exposed Thermal Pad Dimensions

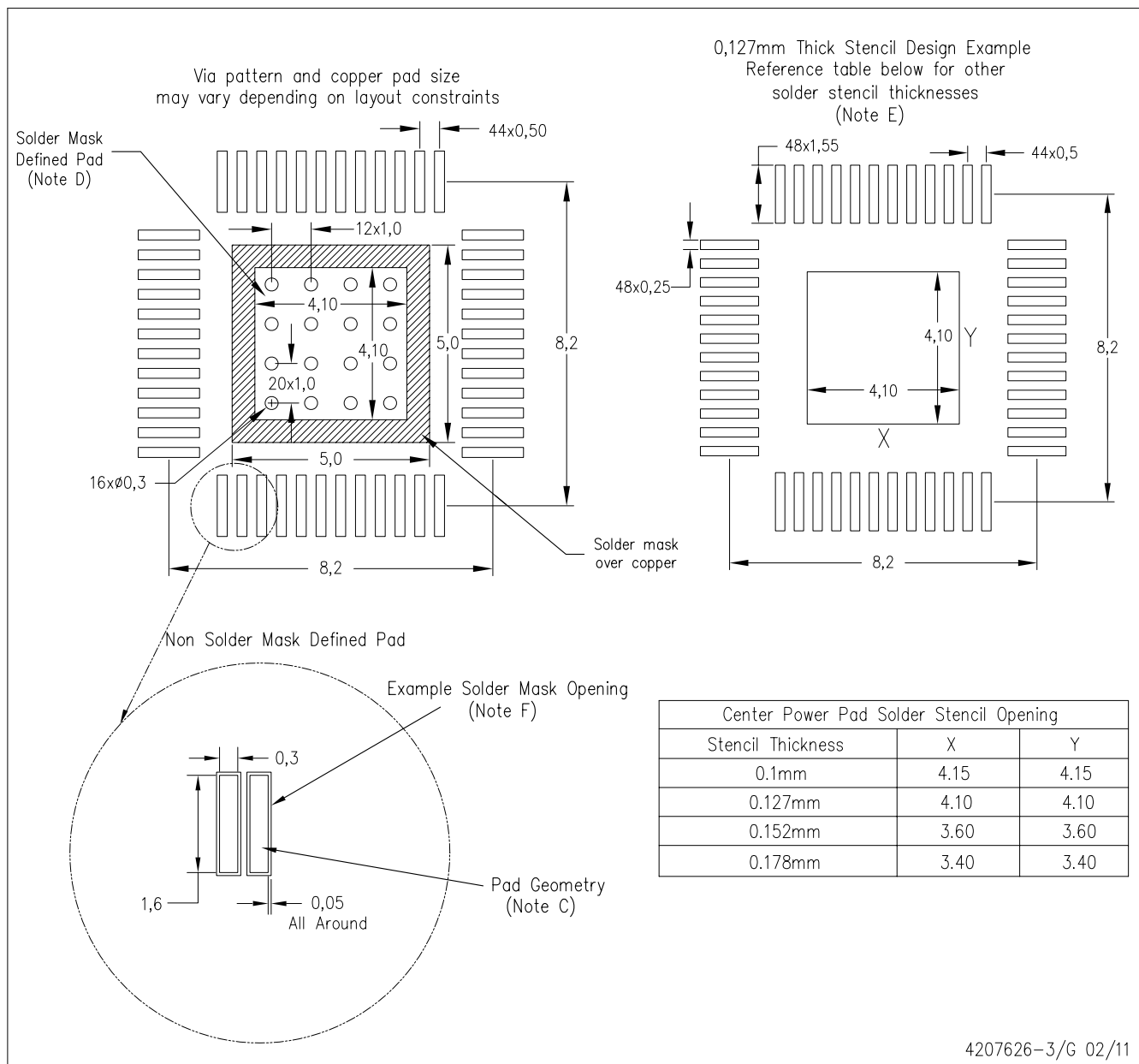
4206329-3/M 01/11

NOTE: A. All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments

PHP (S-PQFP-G48)

PowerPAD™ PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting options for vias placed in the thermal pad.

PowerPAD is a trademark of Texas Instruments



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
RF/IF and ZigBee® Solutions	www.ti.com/lprf

Applications

Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Transportation and Automotive	www.ti.com/automotive
Video and Imaging	www.ti.com/video
Wireless	www.ti.com/wireless-apps

TI E2E Community Home Page

e2e.ti.com

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2011, Texas Instruments Incorporated

www.BDTIC.com/TI